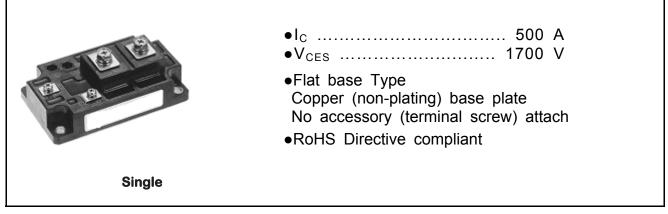
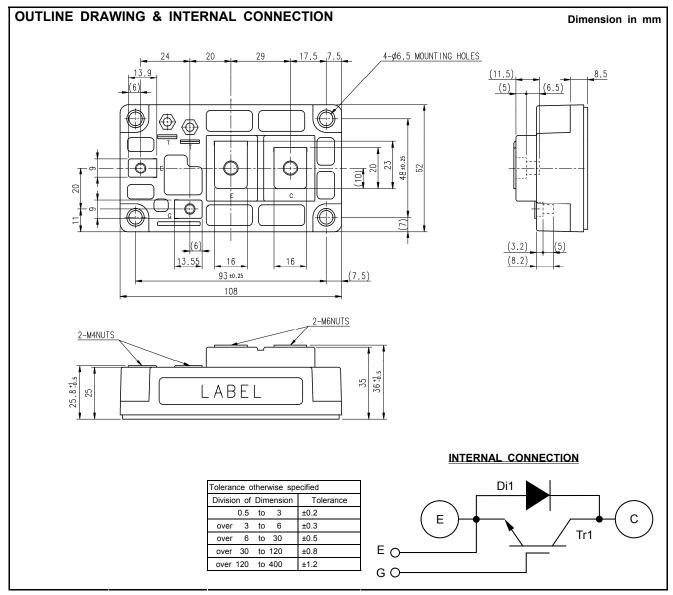
CM500HA-34A



APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.





ABSOLUTE MAXIMUM RATINGS (Tj=25 °C, unless otherwise specified)

	-			
Symbol	Item Conditions		Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V
V _{GES}	Gate-emitter voltage	C-E short-circuited	±20	V
lc	Collector current	DC, T _C =87 °C (Note.2)	500	^
I _{CRM}	Collector current	Pulse, Repetitive (Note.3)	1000	A
Ptot	Total power dissipation	T _C =25 °C ^(Note.2, 4)	5000	W
IE (Note.1)	Emitter current	T _C =25 °C ^(Note.2, 4)	500	^
I _{ERM} (Note.1)	(Free wheeling diode forward current)	Pulse, Repetitive (Note.3)	1000	A
Tj	Junction temperature	-	-40 ~ +150	°C
T _{stg}	Storage temperature	-	-40 ~ +125	
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	3500	V

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
				Min.	Тур.	Max.	Unit
Mt		Main terminals	M 6 screw	1.96	2.45	2.94	
Mt	Mounting torque	Auxiliary terminals	M 4 screw	0.98	1.18	1.47	N∙m
Ms		Mounting to heat sink	M 6 screw	1.96	2.45	2.94	
m	Weight	-		-	480	-	g
e _c	Flatness of base plate	On the centerline X, Y	(Note.5)	±0	-	+100	μm

ELECTRICAL CHARACTERISTICS (T_j =25 °C, unless otherwise specified)

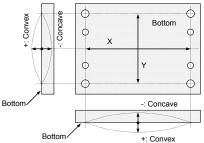
Symbol	Item	Conditions			Limits	Unit	
Symbol	itern	Conditions		Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1	mA
I _{GES}	Gate-emitter leakage current	±V _{GE} =V _{GES} , C-E short-circuited		-	-	3	μA
$V_{\text{GE}(\text{th})}$	Gate-emitter threshold voltage	I _C =50 mA, V _{CE} =10 V		5.5	7	8.5	V
V _{CEsat}	Collector-emitter saturation voltage	I _C =500 A ^(Note.6) ,	T _j =25 °C	-	2.2	3.0	V
		V _{GE} =15 V	Т _ј =125 °С	-	2.45	-	
Cies	Input capacitance	-		-	-	120	
Coes	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	14	nF
Cres	Reverse transfer capacitance			-	-	2.6	
Q_{G}	Gate charge	V _{CC} =1000 V, I _C =500 A, V _{GE} =15 V		-	3300	-	nC
t _{d(on)}	Turn-on delay time	V_{CC} =1000 V, I _C =500 A, V _{GE} =±15 V,		-	-	900	
tr	Rise time			-	-	500	ns
$t_{d(off)}$	Turn-off delay time	R_{G} =3.0 Ω , Inductive load		-	-	700	115
t _f	Fall time			-	-	350	
V _{EC} (Note.1)	Emitter-collector voltage	I _E =500 A ^(Note.6) , G-E short-circuited		-	2.3	3.2	V
t _{rr} ^(Note.1)	Reverse recovery time	V _{CC} =1000 V, I _E =500 A, V _{GE} =±15 V,		-	-	650	ns
Q _{rr} (Note.1)	Reverse recovery charge	R_G =3.0 Ω , Inductive load		-	50	-	μC
Eon	Turn-on switching energy per pulse	V _{CC} =1000 V, I _C =I _E =500 A,		-	267.8	-	
E _{off}	Turn-off switching energy per pulse	V_{GE} =±15 V, R _G =3.0 Ω,		-	138.5	-	mJ
Err (Note.1)	Reverse recovery energy per pulse	T _j =125 °C, Inductive load		-	98.1	-	
r _g	Internal gate resistance	T _C =25 °C		-	1.0	-	Ω
R _G	External gate resistance	-		3.0	-	10	Ω

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions		Limits		Unit
		Conditions	Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance (Note.2)	Junction to case, IGBT part	-	-	25	K/kW
R _{th(j-c)D}		Junction to case, FWDi part	-	-	42	K/kW
$R_{th(c-s)}$	Contact thermal resistance (Note.2)	Case to heat sink, Thermal grease applied ^(Note.7)	-	20	-	K/kW



- Note.1: Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).
- Note.2: Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)
- The heat sink thermal resistance $\{R_{th(s-a)}\}$ should measure just under the chips.
- Note.3: Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating. Note.4: Junction temperature (T_j) should not increase beyond T_{jmax} rating.
- Note 5: Base plate flatness measurement point is as in the following figure.

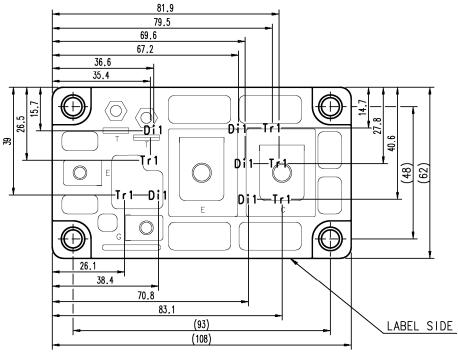


Note.6: Pulse width and repetition rate should be such as to cause negligible temperature rise. (Refer to the figure of test circuit)

Note.7: Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K).

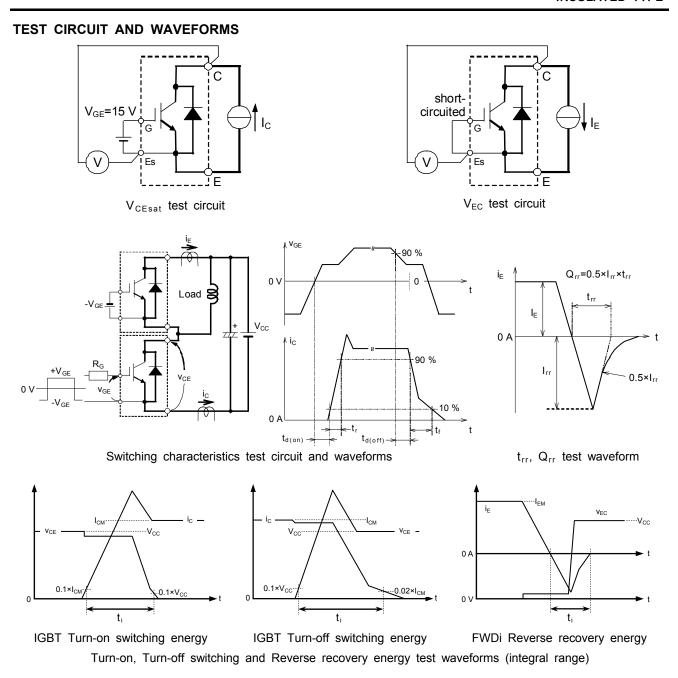
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

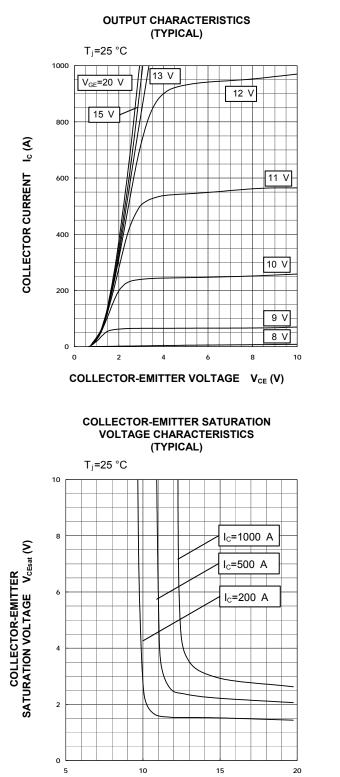


Tr1: IGBT, Di1: FWDi. Each mark points the center position of each chip.

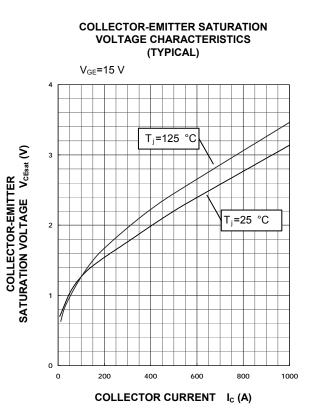




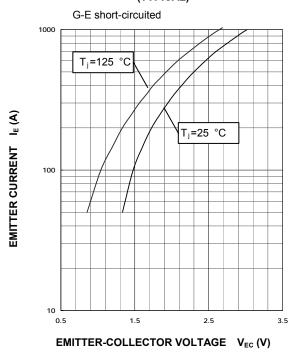
PERFORMANCE CURVES

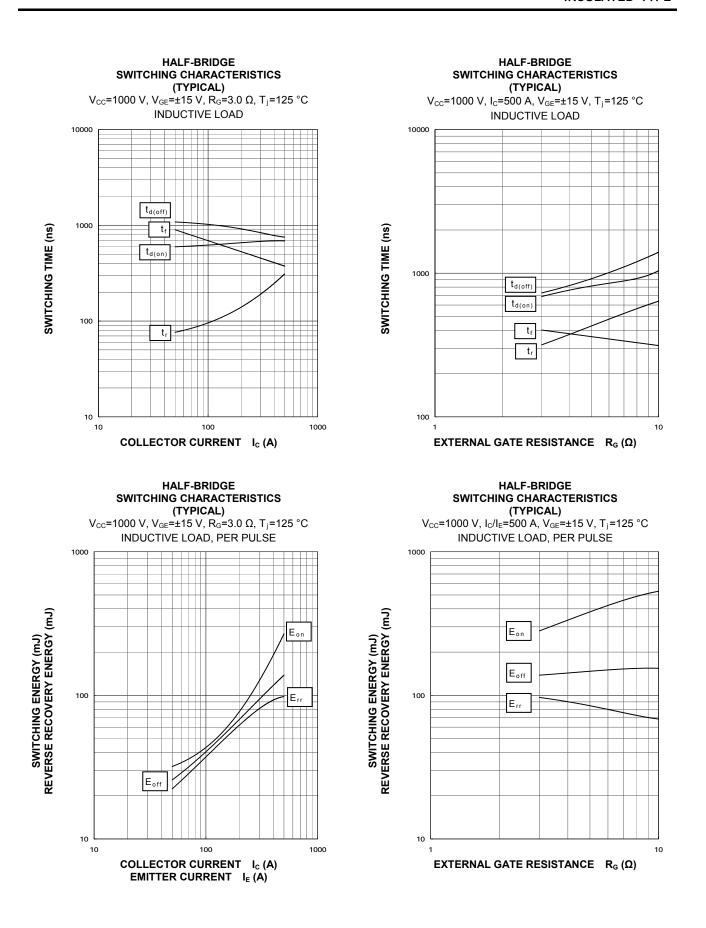


GATE-EMITTER VOLTAGE V_{GE} (V)



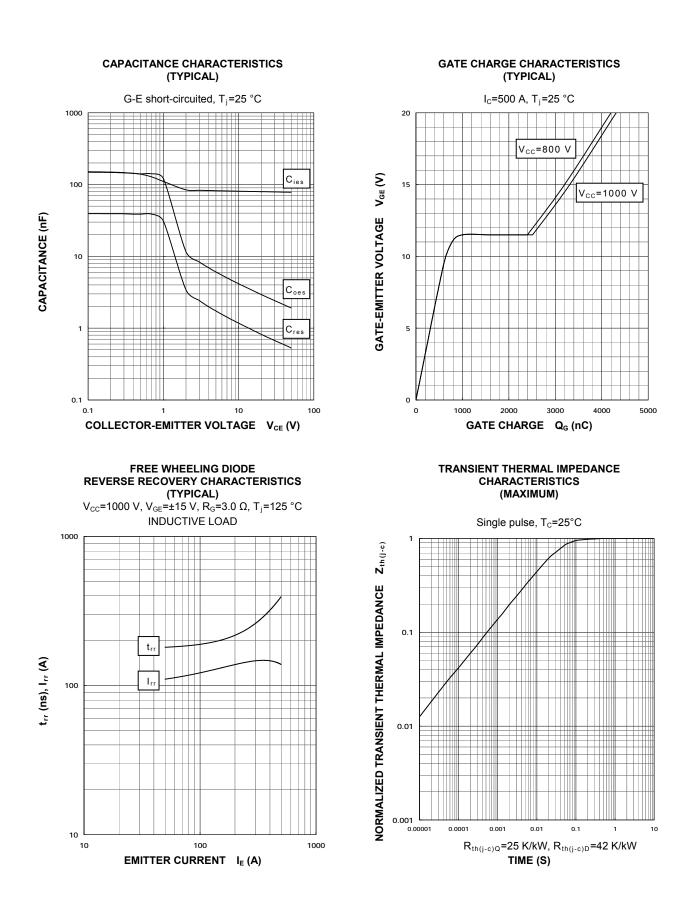
FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)







6





Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

These materials are intended as a reference to assist our customers in the selection of the Mitsubishi semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.

Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.

All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor for the latest product information before purchasing a product listed herein. The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.

Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Semiconductor home page (http://www.mitsubishichips.com/Global/index.html).

When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.

Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.

The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.

If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.

Any diversion or reexport contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.

Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor for further details on these materials or the products contained therein.

